Testing Services™	Appendix D for the BlackB	serry® Smartphone Mod	lel RDS41CW	Page 1(30)
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APPENDIX D: PROBE & DIPOLE CALIBRATION DATA

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Multilateral Agreement for the recognition of calibration certificates

Client RTS (RIM Testing Services)

Certificate No: ES3-3225 Jan11

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE ES3DV3 - SN:3225 Object QA CAL-01.v7, QA CAL-23.v4 and QA CAL-25.v3 Calibration procedure(s) Calibration procedure for dosimetric E-field probes January 13, 2011 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI), The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) ID# Primary Standards Cal Date (Certificate No.) Scheduled Calibration GB41293874 1-Apr-10 (No. 217-01136) Power meter E4419B Apr-11 Power sensor E4412A MY41495277 1-Apr-10 (No. 217-01136) Apr-11 Power sensor E4412A MY41498087 1-Apr-10 (No. 217-01136) Apr-11 Reference 3 dB Attenuator SN: S5054 (3c) 30-Mar-10 (No. 217-01159) Mar-11 SN: S5086 (20b) Reference 20 dB Attenuator 30-Mar-10 (No. 217-01161) Mar-11 Reference 30 dB Attenuator SN: S5129 (30b) 30-Mar-10 (No. 217-01160) Mar-11 Reference Probe ES3DV2 SN: 3013 29-Dec-10 (No. ES3-3013 Dec10) Dec-11 SN: 660 DAE4 20-Apr-10 (No. DAE4-660_Apr10) Apr-11 Secondary Standards ID# Check Date (in house) Scheduled Check RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Oct-09) In house check: Oct-11 US37390585 Network Analyzer HP 8753E 18-Oct-01 (in house check Oct-10) In house check: Oct-11 Signature Calibrated by: Approved by: Issued: January 15, 2011 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ES3-3225_Jan11

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Testing Services™	Appendix D for the Black	Berry® Smartphone Moo	lel RDS41CW	Page 3(30)
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Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

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Swiss Calibration Service Accreditation No.: SCS 108

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Glossary:

tissue simulating liquid TSL. NORMx,y,z sensitivity in free space ConvF sensitivity in TSL / NORMx,y,z DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization o φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization 9 = 0 (f < 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E2-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y, z = NORMx, y, z * frequency response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx, y,z; DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

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Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Probe ES3DV3

SN:3225

Manufactured: September 1, 2009 Last calibrated: December 11, 2009 Recalibrated: January 13, 2011

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

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Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) ²) ^A	1.26	1.21	1.31	± 10.1%
DCP (mV) ^B	102.1	100.8	99.1	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	С	VR mV	Unc ^E (k=2)
10000	cw	0.00	×	0.00	0.00	1.00	149.8	± 2.6 %
			Υ	0.00	0.00	1.00	148.1	
			Z	0.00	0.00	1.00	110.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ES3-3225_Jan11

^a The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

⁸ Numerical linearization parameter, uncertainty not required.

⁶ Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

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ES3DV3 SN:3225

January 13, 2011

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Co	nvF Z	Alpha	Depth Unc (k=2)
750	±50/±100	41.9 ± 5%	$0.89 \pm 5\%$	6.47	6.47	6.47	0.89	1.08 ± 11.0%
900	± 50 / ± 100	$41.5 \pm 5\%$	$0.97 \pm 5\%$	6.11	6.11	6.11	0.81	1.10 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	$1.40 \pm 5\%$	5.26	5.26	5.26	0.37	1.68 ± 11.0%
1950	±50/±100	$40.0\pm5\%$	$1.40 \pm 5\%$	4.98	4.98	4.98	0.48	1.51 ± 11.0%
2450	±50/±100	39.2 ± 5%	$1.80 \pm 5\%$	4.60	4.60	4.60	0.52	1.54 ± 11.0%
2600	± 50 / ± 100	$39.0 \pm 5\%$	1.96 ± 5%	4.52	4.52	4.52	0.53	1.58 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Body Tissue Simulating Media

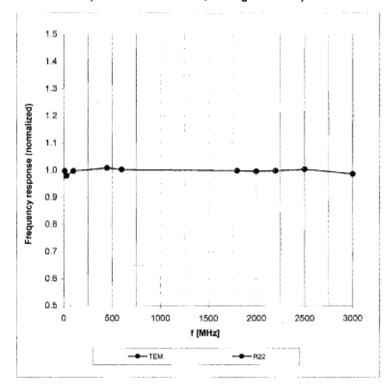
f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Cor	vF Z	Alpha	Depth Unc (k=2)
750	±50/±100	$55.5 \pm 5\%$	$0.96 \pm 5\%$	6.30	6.30	6.30	0.76	1.17 ± 11.0%
900	±50/±100	$55.0 \pm 5\%$	1.05 ± 5%	6.12	6.12	6.12	0.72	1.20 ± 11.0%
1810	±50/±100	53.3 ± 5%	1.52 ± 5%	4.88	4.88	4.88	0.26	2.70 ± 11.0%
1950	±50/±100	$53.3\pm5\%$	1.52 ± 5%	4.89	4.89	4.89	0.33	2.28 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	$1.95 \pm 5\%$	4.43	4.43	4.43	0.99	1.04 ± 11.0%
2600	±50/±100	52.5 ± 5%	2.16 ± 5%	4.29	4.29	4.29	0.99	1.05 ± 11.0%

The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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Frequency Response of E-Field

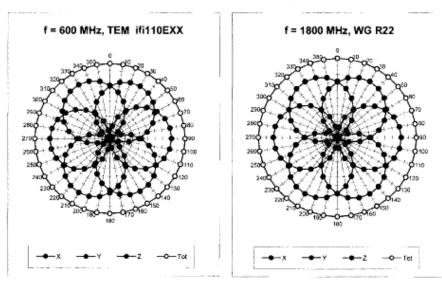
(TEM-Cell:ifi110 EXX, Waveguide: R22)

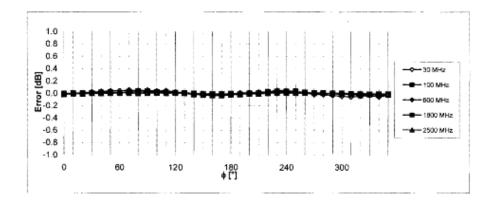


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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Receiving Pattern (ϕ), ϑ = 0°



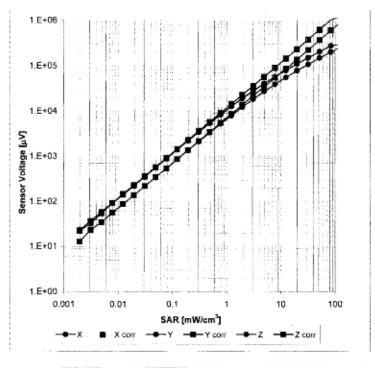


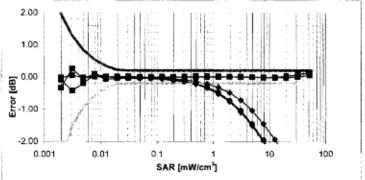
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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Dynamic Range f(SAR_{head})

(TEM cell, f = 900 MHz)

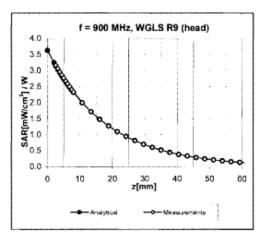


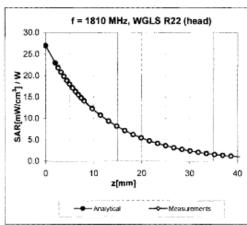


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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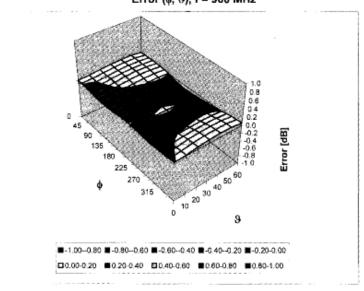
Conversion Factor Assessment





Deviation from Isotropy in HSL

Error (♦, ३), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm

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RTS (RIM Testing Services)

Accreditation No.: SCS 108

Certificate No: D835V2-446 Jan11 CALIBRATION CERTIFICATE D835V2 - SN: 446 Object QA CAL-05.v8 Calibration procedure(s) Calibration procedure for dipole validation kits Calibration date: January 21, 2011 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration Power meter EPM-442A GB37480704 06-Oct-10 (No. 217-01266) Oct-11 Power sensor HP 8481A US37292783 06-Oct-10 (No. 217-01266) Oct-11 Reference 20 dB Attenuator SN: 5086 (20g) 30-Mar-10 (No. 217-01158) Mar-11 SN: 5047.2 / 06327 Type-N mismatch combination 30-Mar-10 (No. 217-01162) Mar-11 Reference Probe ES3DV3 SN: 3205 30-Apr-10 (No. ES3-3205_Apr10) Apr-11 DAE4 SN: 601 10-Jun-10 (No. DAE4-601_Jun10) Jun-11 Secondary Standards ID# Check Date (in house) Scheduled Check Power sensor HP 8481A MY41092317 18-Oct-02 (in house check Oct-09) In house check: Oct-11 RF generator R&S SMT-06 100005 4-Aug-99 (in house check Oct-09) In house check: Oct-11 Network Analyzer HP 8753E US37390585 S4206 18-Oct-01 (in house check Oct-10) In house check: Oct-11 Function Calibrated by: Laboratory Technician Approved by: Issued: January 21, 2011 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Glossarv:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,y,z not applicable or not measured

N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.3 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature during test	(21.8 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.39 mW / g
SAR normalized	normalized to 1W	9.56 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.63 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.56 mW / g
SAR normalized	normalized to 1W	6.24 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.27 mW /g ± 16.5 % (k=2)

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.6 Ω - 7.7 jΩ
Return Loss	- 22.2 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.386 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 24, 2001

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Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	2503A-RDS40CW		

DASY5 Validation Report for Head TSL

Date/Time: 21.01.2011 10:18:05

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL900

Medium parameters used: f = 835 MHz; $\sigma = 0.89 \text{ mho/m}$; $\epsilon_r = 41.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(6.03, 6.03, 6.03); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

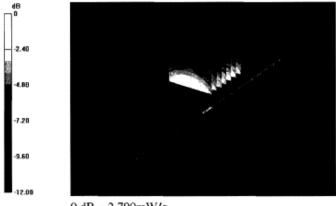
Pin=250 mW /d=15mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 57.426 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 3.600 W/kg

SAR(1 g) = 2.39 mW/g; SAR(10 g) = 1.56 mW/gMaximum value of SAR (measured) = 2.790 mW/g

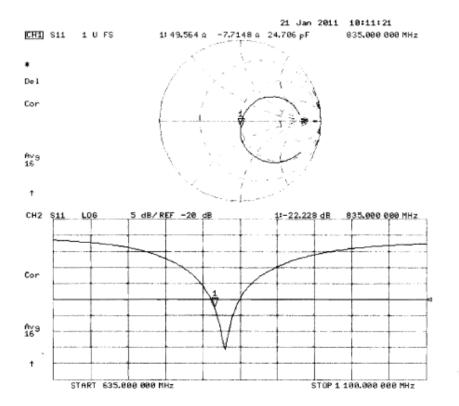


0 dB = 2.790 mW/g

Certificate No: D835V2-446_Jan11

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Impedance Measurement Plot for Head TSL



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Client RTS (RIM Testing Services)

Certificate No: D1900V2-545 Jan11

CALIBRATION CERTIFICATE D1900V2 - SN: 545 Object QA CAL-05.v8 Calibration procedure(s) Calibration procedure for dipole validation kits January 13, 2011 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration Power meter EPM-442A GB37480704 06-Oct-10 (No. 217-01266) Oct-11 Power sensor HP 8481A US37292783 06-Oct-10 (No. 217-01266) Oct-11 Reference 20 dB Attenuator SN: 5086 (20g) 30-Mar-10 (No. 217-01158) Mar-11 Type-N mismatch combination SN: 5047.2 / 06327 30-Mar-10 (No. 217-01162) Mar-11 Reference Probe ES3DV3 SN: 3205 30-Apr-10 (No. ES3-3205_Apr10) Apr-11 DAE4 SN: 601 10-Jun-10 (No. DAE4-601_Jun10) Jun-11 Secondary Standards ID# Check Date (in house) Scheduled Check MY41092317 Power sensor HP 8481A 18-Oct-02 (in house check Oct-09) In house check: Oct-11 RF generator R&S SMT-06 100005 4-Aug-99 (in house check Oct-09) In house check: Oct-11 Network Analyzer HP 8753E US37390585 S4206 18-Oct-01 (in house check Oct-10) In house check: Oct-11 Laboratory Technician Calibrated by: Approved by: Issued: January 14, 2011 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D1900V2-545_Jan11

Page 1 of 6

Testing Services™	Appendix D for the BlackB	erry® Smartphone Mod	lel RDS41CW	Page 20(30)
Author Data	Dates of Test	Test Report No	IC ID	
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	2503A-RDS40CW	

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst

Service suisse d'étalonnage Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,y,z not applicable or not measured

N/A not applicable or not mea

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Certificate No: D1900V2-545_Jan11

Testing Services™	Testing Services™ Appendix D for the BlackBerry® Smartphone Model RDS41CW			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	38.5 ± 6 %	1.43 mho/m ± 6 %
Head TSL temperature during test	(21.2 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	40.0 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.26 mW / g
SAR normalized	normalized to 1W	21.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	20.8 mW /g ± 16.5 % (k=2)

Testing Services™	Appendix D for the Black	Berry® Smartphone Mo	odel RDS41CW	Page 22(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.8 Ω + 1.8 jΩ
Return Loss	- 34.4 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.199 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	November 15, 2001

Certificate No: D1900V2-545_Jan11

Testing Services™				Page 23(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 14:52:49

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used: f = 1900 MHz; $\sigma = 1.43 \text{ mho/m}$; $\varepsilon_r = 38.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.09, 5.09, 5.09); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.053 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 18.648 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.26 mW/gMaximum value of SAR (measured) = 12.743 mW/g

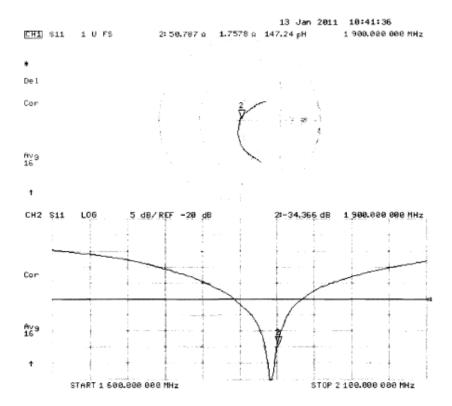


0 dB = 12.740 mW/g

Certificate No: D1900V2-545_Jan11

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Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	2503A-RDS40CW		

Impedance Measurement Plot for Head TSL



Testing Services	Appendix D for the Black	xBerry® Smartphone Mo	odel RDS41CW	Page 25(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Calibration Laboratory of Schmid & Partner Engineering AG





Schweizerischer Kalibrierdienst s Service suisse d'étalonnage С Servizio svizzero di taratura Swiss Calibration Service

Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

RTS (RIM Testing Services) Certificate No: D2450V2-747_Nov09 Client

CALIBRATION CERTIFICAT D2450V2 - SN: 747 Object QA CAL-05.V7 Calibration procedure(s) Calibration procedure for dipole validation kits Calibration date: November 11, 2009 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3) °C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards Cal Date (Certificate No.) Scheduled Calibration Power meter EPM-442A GB37480704 06-Oct-09 (No. 217-01086) Oct-10 Power sensor HP 8481A US37292783 06-Oct-09 (No. 217-01086) Oct-10 Reference 20 dB Attenuator SN: 5086 (20g) 31-Mar-09 (No. 217-01025) Mar-10 Type-N mismatch combination SN: 5047.2 / 06327 31-Mar-09 (No. 217-01029) Mar-10 Reference Probe ES3DV3 SN: 3205 26-Jun-09 (No. ES3-3205_Jun09) Jun-10 DAE4 SN: 601 07-Mar-09 (No. DAE4-601_Mar09) Mar-10 Secondary Standards ID# Check Date (in house) Scheduled Check Power sensor HP 8481A MY41092317 18-Oct-02 (in house check Oct-09) In house check: Oct-11 RF generator R&S SMT-06 100005 4-Aug-99 (in house check Oct-09) In house check: Oct-11 Network Analyzer HP 8753E US37390585 S4206 18-Oct-01 (in house check Oct-09) In house check: Oct-10 Signature Name Function Calibrated by: Approved by: Issued: November 16, 2009 This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: D2450V2-747_Nov09 Page 1 of 6

Testing Services™	Appendix D for the BlackBerry® Smartphone Model RDS41CW			Page 26(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 108

Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point.
 No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D2450V2-747_Nov09 Page 2 of 6

Testing Services™	Appendix D for the BlackBerry® Smartphone Model RDS41CW			Page 27 (30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.1 ± 6 %	1.78 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm3 (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.3 mW / g
SAR normalized	normalized to 1W	53.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	53.4 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.23 mW / g
SAR normalized	normalized to 1W	24.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.9 mW/g ± 16.5 % (k=2)

Testing Services™	Appendix D for the BlackB	Appendix D for the BlackBerry® Smartphone Model RDS41CW		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.9 Ω + 0.9 jΩ
Return Loss	- 33.9 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.161 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG		
Manufactured on	December 01, 2003		

Certificate No: D2450V2-747_Nov09

Testing Services™	Appendix D for the BlackB	erry® Smartphone Mod	lel RDS41CW	Page 29(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

DASY5 Validation Report for Head TSL

Date/Time: 11.11.2009 15:04:10

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:747

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U11 BB

Medium parameters used: f = 2450 MHz; $\sigma = 1.79 \text{ mho/m}$; $\varepsilon_r = 39.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(4.53, 4.53, 4.53); Calibrated: 26.06.2009

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 07.03.2009

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Head/d=10mm, Pin=250 mW, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) (7x7x7)/Cube 0:

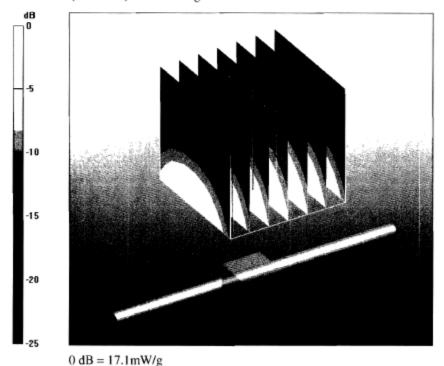
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 101.3 V/m; Power Drift = 0.067 dB

Peak SAR (extrapolated) = 27 W/kg

SAR(1 g) = 13.3 mW/g; SAR(10 g) = 6.23 mW/g

Maximum value of SAR (measured) = 17.1 mW/g



Certificate No: D2450V2-747_Nov09

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Testing Services™	Appendix D for the BlackE	Berry® Smartphone Moo	del RDS41CW	Page 30(30)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	May 3 – June 28, 2011	RTS-2604-1107-06	L6ARDS40CW	2503A-RDS40CW

Impedance Measurement Plot for Head TSL

